


<b>Search Notes</b>  	<b>Application/Control No.</b>  10536732	<b>Applicant(s)/Patent Under Reexamination</b>  DESMICHT ET AL.
	<b>Examiner</b>  Izunna Okeke	<b>Art Unit</b>  2432

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
Updated Classification + Keyword Search (See History)	3/28/2011	IO
Updated Text Search (See History)	3/28/2011	IO
Updated Classification Search (713/193, 711/101, 711/103, 711/104, 711/163, 711/164, 711/145) (See History)	3/17/2010	IO
NPL Search (Google Scholar, IEEEExplore database)	3/28/2011	IO

INTERFERENCE SEARCH			
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